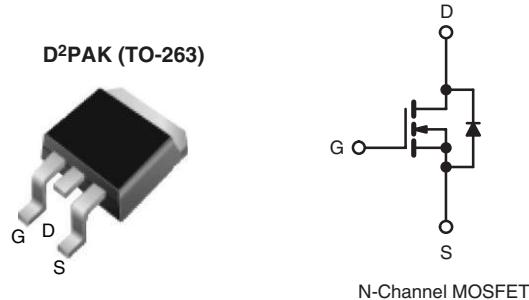


Power MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	100	
$R_{DS(on)}$ (Ω)	$V_{GS} = 10$ V	0.077
Q_g (Max.) (nC)	72	
Q_{gs} (nC)	11	
Q_{gd} (nC)	32	
Configuration	Single	



FEATURES

- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- 175 °C Operating Temperature
- Fast Switching
- Ease of Parallelizing
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D²PAK (TO-263) is a surface mount power package capable of accommodating die size up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION

Package	D ² PAK (TO-263)	D ² PAK (TO-263)	D ² PAK (TO-263)
Lead (Pb)-free	IRF540SPbF	IRF540STRLPbFa	IRF540STRRPbFa
	SiHF540S-E3	SiHF540STL-E3 ^a	SiHF540STR-E3 ^a
SnPb	IRF540S	IRF540STRLa	IRF540STRRa
	SiHF540S	SiHF540STLa	SiHF540STRa

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	100	
Gate-Source Voltage			V_{GS}	± 20	
Continuous Drain Current	V_{GS} at 10 V	$T_C = 25$ °C	I_D	28	A
		$T_C = 100$ °C		20	
Pulsed Drain Current ^a			I_{DM}	110	
Linear Derating Factor				1.0	W/°C
				0.025	
Single Pulse Avalanche Energy ^b			E_{AS}	230	mJ
Avalanche Current ^a			I_{AR}	28	A
Repetitive Avalanche Energy ^a			E_{AR}	15	mJ
Maximum Power Dissipation	$T_C = 25$ °C		P_D	150	W
	$T_A = 25$ °C			3.7	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns
Operating Junction and Storage Temperature Range			T_J, T_{stg}	- 55 to + 175	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	°C

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 25$ V, starting $T_J = 25$ °C, $L = 440$ μ H, $R_G = 25$ Ω , $I_{AS} = 28$ A (see fig. 12).
- $I_{SD} \leq 28$ A, $dI/dt \leq 170$ A/ μ s, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C.
- 1.6 mm from case.
- When mounted on 1" square PCB (FR-4 or G-10 material).

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R_{thJA}	-	62	$^{\circ}\text{C}/\text{W}$
Maximum Junction-to-Ambient (PCB Mount) ^a	R_{thJA}	-	40	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	1.0	

Note

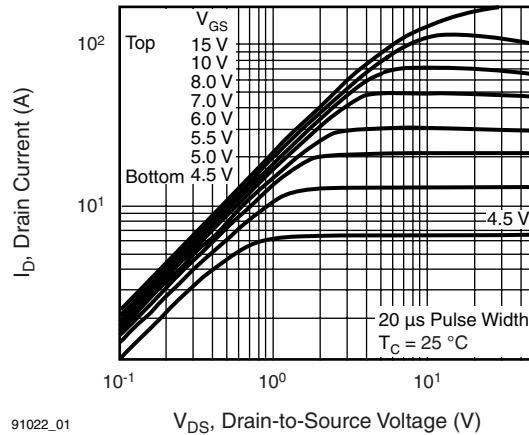
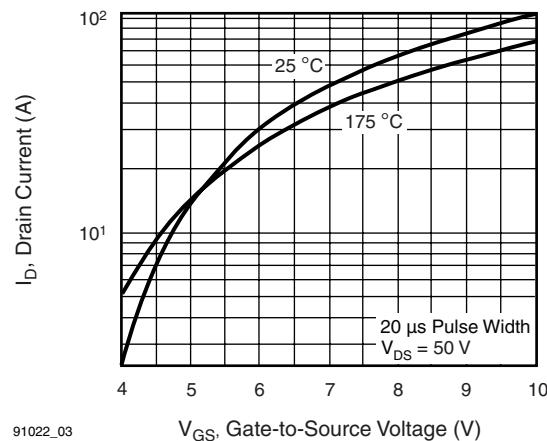
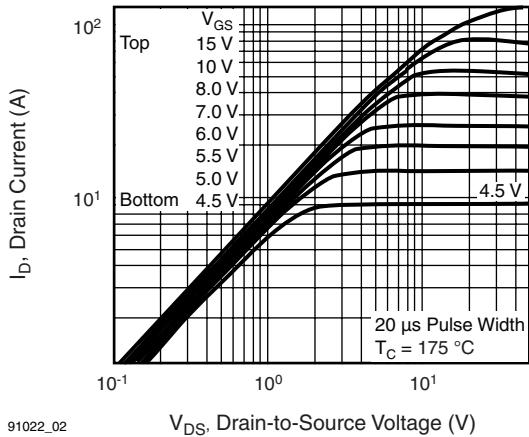
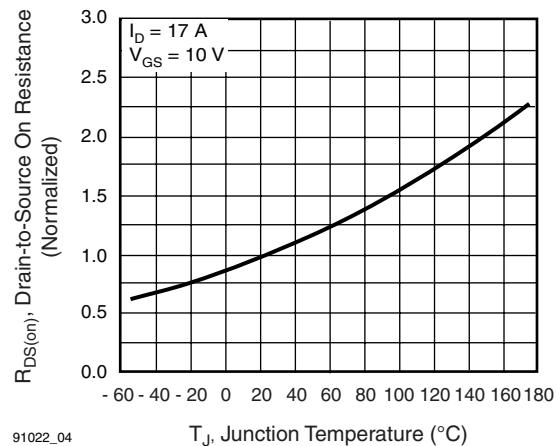
- a. When mounted on 1" square PCB (FR-4 or G-10 material).

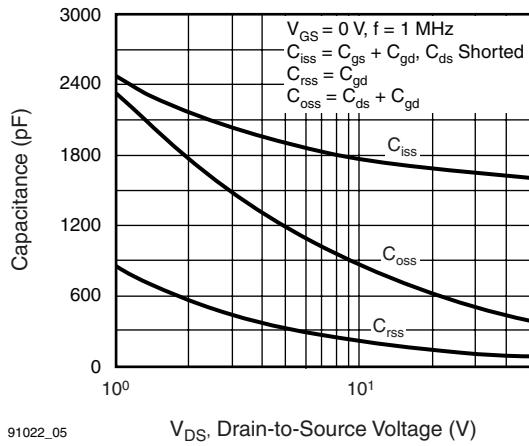
SPECIFICATIONS $T_J = 25 \text{ }^{\circ}\text{C}$, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100	-	-	V	
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25 \text{ }^{\circ}\text{C}$, $I_D = 1 \text{ mA}$		-	0.13	-	$^{\circ}\text{C}/\text{V}$	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		2.0	-	4.0	V	
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	25	μA	
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ }^{\circ}\text{C}$		-	-	250		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 17 \text{ A}^b$	-	-	0.077	Ω	
Forward Transconductance	g_{fs}	$V_{DS} = 50 \text{ V}, I_D = 17 \text{ A}^b$		8.7	-	-	S	
Dynamic								
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1.0 \text{ MHz}$, see fig. 5		-	1700	-	pF	
Output Capacitance	C_{oss}			-	560	-		
Reverse Transfer Capacitance	C_{rss}			-	120	-		
Total Gate Charge	Q_g	$V_{GS} = 10 \text{ V}$	$I_D = 17 \text{ A}, V_{DS} = 80 \text{ V}$, see fig. 6 and 13 ^b	-	-	72	nC	
Gate-Source Charge	Q_{gs}			-	-	11		
Gate-Drain Charge	Q_{gd}			-	-	32		
Turn-On Delay Time	$t_{d(on)}$			-	11	-		
Rise Time	t_r	$V_{DD} = 50 \text{ V}, I_D = 17 \text{ A}, R_G = 9.1 \Omega, R_D = 2.9 \Omega$, see fig. 10 ^b		-	44	-	ns	
Turn-Off Delay Time	$t_{d(off)}$			-	53	-		
Fall Time	t_f			-	43	-		
Internal Drain Inductance	L_D			-	4.5	-	nH	
Internal Source Inductance	L_S	Between lead, 6 mm (0.25") from package and center of die contact		-	7.5	-		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	28	A	
Pulsed Diode Forward Current ^a	I_{SM}			-	-	110		
Body Diode Voltage	V_{SD}	$T_J = 25 \text{ }^{\circ}\text{C}, I_S = 28 \text{ A}, V_{GS} = 0 \text{ V}^b$		-	-	2.5	V	
Body Diode Reverse Recovery Time	t_{rr}	$T_J = 25 \text{ }^{\circ}\text{C}, I_F = 17 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	180	360	ns	
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.3	2.8	μC	
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						

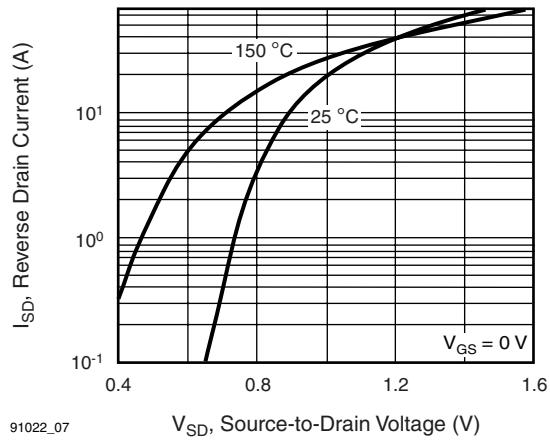
Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2 \%$.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics, $T_C = 25 \text{ }^\circ\text{C}$

Fig. 3 - Typical Transfer Characteristics

Fig. 2 - Typical Output Characteristics, $T_C = 175 \text{ }^\circ\text{C}$

Fig. 4 - Normalized On-Resistance vs. Temperature



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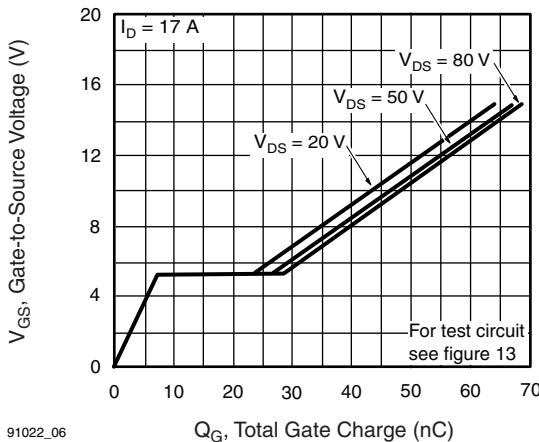
 V_{DS} , Drain-to-Source Voltage (V)

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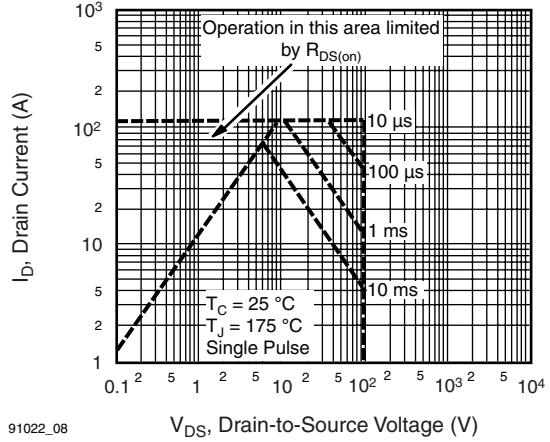
 V_{SD} , Source-to-Drain Voltage (V)

Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 7 - Typical Source-Drain Diode Forward Voltage



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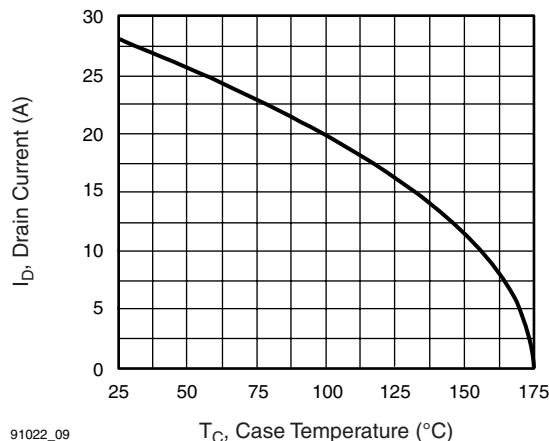
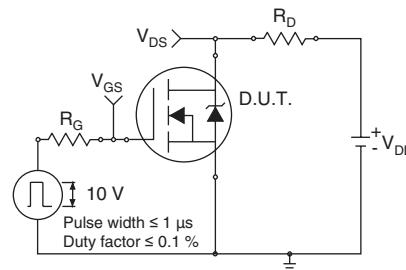
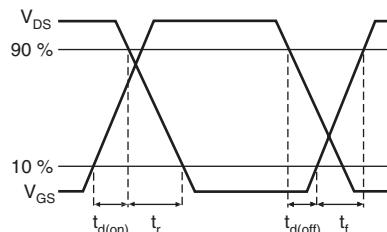
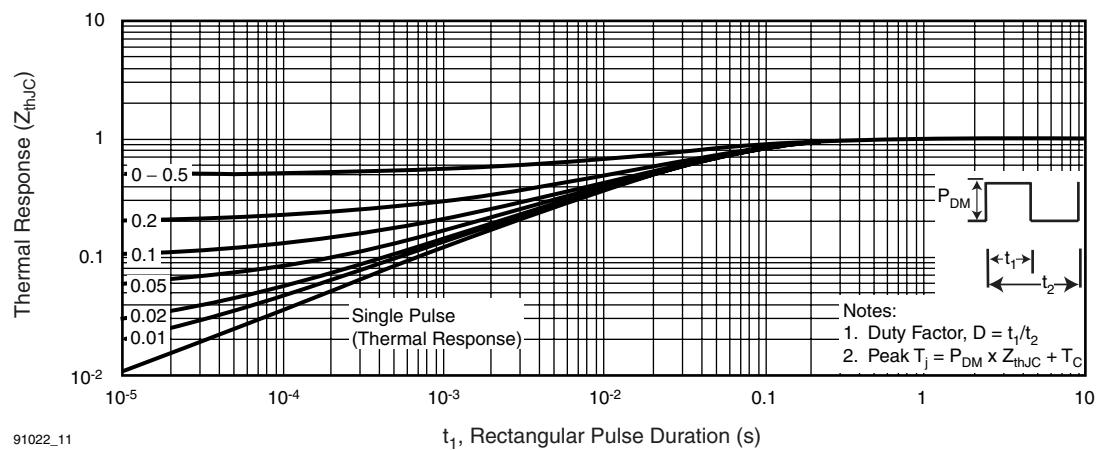
 Q_G , Total Gate Charge (nC)

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 V_{DS} , Drain-to-Source Voltage (V)

Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 8 - Maximum Safe Operating Area


Fig. 9 - Maximum Drain Current vs. Case Temperature

Fig. 10a - Switching Time Test Circuit

Fig. 10b - Switching Time Waveforms

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

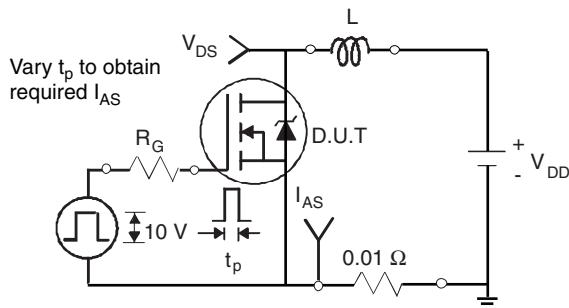


Fig. 12a - Unclamped Inductive Test Circuit

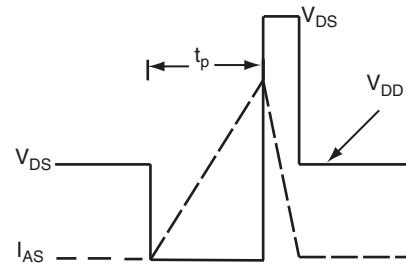


Fig. 12b - Unclamped Inductive Waveforms

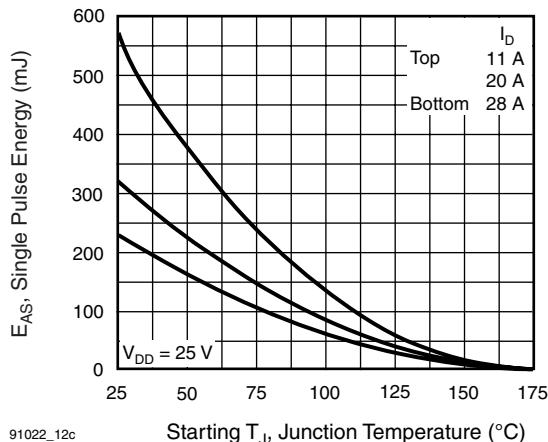


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

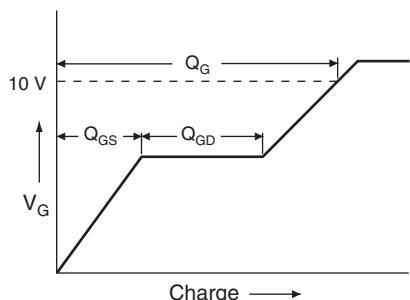


Fig. 13a - Basic Gate Charge Waveform

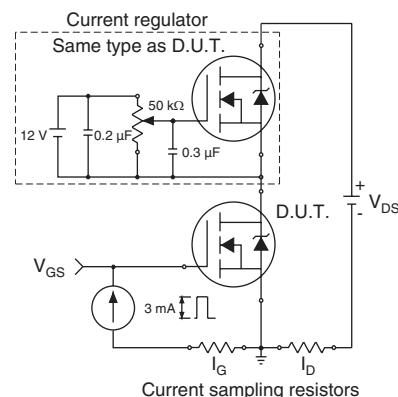
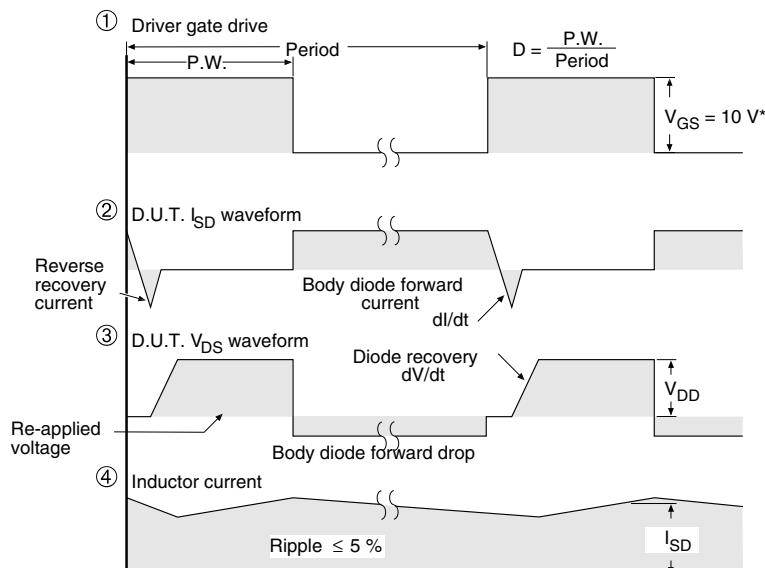
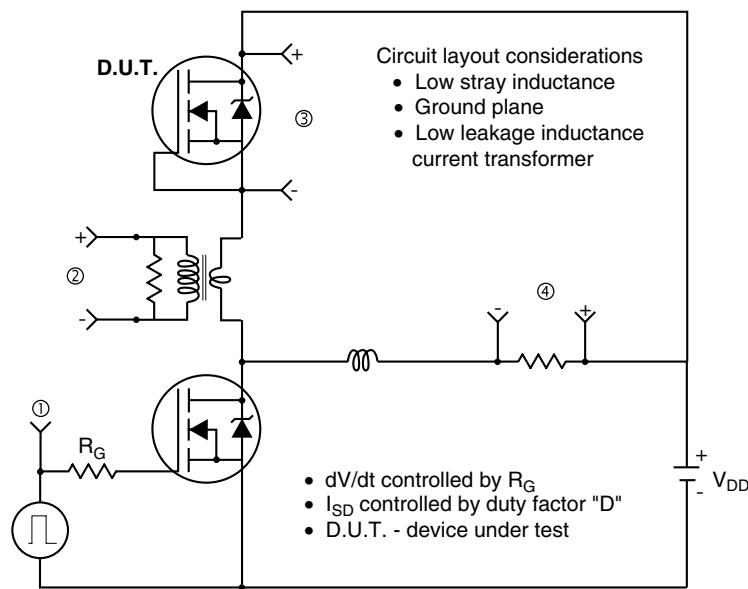


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = 5 \text{ V}$ for logic level and 3 V drive devices

Fig. 14 - For N-Channel

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